Special Issue

Image Processing: Technologies, Methods, Apparatus

Message from the Guest Editors

Image processing is at the forefront of technological research, with significant breakthroughs. Within this background, this Special Issue aims to provide a concise collection of studies dealing with image processing and provide important information to scientists and stakeholders for the development of technologies and systems based on sensors. Articles and review articles may address, but are not limited to, the following topics:

- Novel algorithms for image enhancement, segmentation, and recognition;
- Machine learning and Al applications in image processing;
- Computational imaging techniques;
- Hardware and software innovations for image acquisition and analysis;
- Biomedical, industrial, and security applications of image processing;
- High-rate detector and an event detector.

Guest Editors

Dr. Benjamin Milgrom

Prof. Dr. Andrei Doncescu

Prof. Dr. Cheonshik Kim

Prof. Dr. Ki-Hyun Jung

Deadline for manuscript submissions

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Applied Sciences
Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland
Tel: +41 61 683 77 34
applisci@mdpi.com

mdpi.com/journal/applsci





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About the Journal

Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo

Dipartimento di Fisica, Politecnico di Milano, Piazza L. da Vinci 32, 20133 Milano, Italy

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